

# **RSEN-2200**

## **RELIABILITY DATA**

| DWG. No.SC575-RSEN-200-001 |                             |                           |                          |
|----------------------------|-----------------------------|---------------------------|--------------------------|
| QA                         | R&D                         |                           |                          |
| APPROVED BY                | APPROVED BY                 | CHECKED BY                | DRAWN BY                 |
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The following data are typical values. As all units have nearly the same characteristics, the data to be considered as ability values.

## 1. Calculated values of MTBF

MODEL : RSEN-2200

## (1) Calculating Method

Calculated based on parts stress reliability projection of MIL-HDBK-217F NOTICE2.

Individual failure rates  $\lambda_G$  is given to each part and MTBF is calculated by the count of each part.

$$MTBF = \frac{1}{\lambda_{equip}} = \frac{1}{\sum_{i=1}^n N_i (\lambda_G \pi_Q)_i} \times 10^6 \text{ (hours)}$$

- $\lambda_{equip}$  : Total equipment failure rate (Failure /  $10^6$  Hours)  
 $\lambda_G$  : Generic failure rate for the  $i$ th generic part (Failure/  $10^6$  Hours)  
 $N_i$  : Quantity of  $i$ th generic part  
 $N$  : Number of different generic part categories  
 $\pi_Q$  : Generic quality factor for the  $i$ th generic part ( $\pi_Q = 1$ )

## (2) MTBF Values

$G_F$  : Ground, Fixed

$$\underline{MTBF = 5,235,054 \text{ (Hours)}}$$

## 2. Vibration Test

MODEL : RSEN-2200 (Representation Product : RTHN-5150)

### (1) Vibration Test Class

Frequency Variable Endurance Test

### (2) Equipment Used

Controller VS-1000-6, Vibrator 905-FN ( IMV CORP.)

### (3) The Number of D.U.T. (Device Under Test)

2 units

### (4) Test Condition

- Frequency : 10~55Hz
- Amplitude : 0.7mm, Sweep for 1 min.
- Dimension and times : X, Y and Z directions for 0.5 hours each.

### (5) Test Method

Fix the D.U.T. on the fitting-stage

### (6) Test Results

PASS

### Typical Sample Data

| Check item                | Spec.                                    |         | Before Test           | After Test            |
|---------------------------|--|---------|-----------------------|-----------------------|
| Attenuation (dB)          | Differential Mode : 25dBmin.             | 0.2 MHz | 75.15                 | 75.10                 |
|                           |  | 30 MHz  | 56.05                 | 56.05                 |
|                           | Common Mode : 25dBmin.                   | 0.1 MHz | 32.80                 | 32.80                 |
|                           |  | 10 MHz  | 38.70                 | 38.20                 |
| Leakage Current (mA)      | 5mA max.(500V, 60Hz)                     | Line1   | 2.68                  | 2.67                  |
|                           |  | Line2   | 2.68                  | 2.67                  |
|                           |  | Line3   | 2.69                  | 2.68                  |
| DC Resistance (mΩ)        | 6m Ω max.                                |         | 2.54                  | 2.54                  |
| Test Voltage              | L-L : 2192Vdc 60s.<br>L-E : 2500Vac 60s. |         | OK                    | OK                    |
| Isolation Resistance (MΩ) | 100M Ω min. (500Vdc 60s)                 |         | 1.0 x 10 <sup>7</sup> | 1.0 x 10 <sup>7</sup> |

### 3. Heat Cycle Test

MODEL : RSEN-2200 (Representation Product : RTHN-5150)

(1) Equipment Used

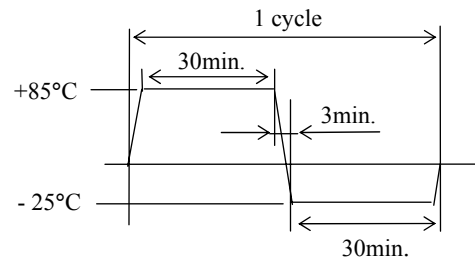
TEMPERATURE CHAMBER TSA-71H-W (ESPEC CORP.)

(2) The Number of D.U.T. (Device Under Test)

2 units

(3) Test Conditions

- Ambient Temperature : -25~+85°C
- Test Cycles : 100cycles



(4) Test Method

Before the test check if there is no abnormal characteristics and put the D.U.T. in the testing chamber. Then test it in the above cycles, After the test is completed leave it for 1 hour at room temperature and check it if there is no abnormal each characteristics.

(5) Test Results

PASS

#### Typical Sample Data

| Check item                | Spec.                                    |         | Before Test           | After Test            |
|---------------------------|--|---------|-----------------------|-----------------------|
| Attenuation (dB)          | Differential Mode : 25dBmin.             | 0.2 MHz | 68.95                 | 73.65                 |
|                           |  | 30 MHz  | 57.70                 | 54.75                 |
|                           | Common Mode : 25dBmin.                   | 0.1 MHz | 33.50                 | 31.50                 |
|                           |  | 10 MHz  | 40.25                 | 40.40                 |
| Leakage Current (mA)      | 5mA max.(500V, 60Hz)                     | Line1   | 2.69                  | 2.63                  |
|                           |  | Line2   | 2.67                  | 2.65                  |
|                           |  | Line3   | 2.67                  | 2.65                  |
| DC Resistance (mΩ)        | 6m Ω max.                                |         | 2.47                  | 2.44                  |
| Test Voltage              | L-L : 2192Vdc 60s.<br>L-E : 2500Vac 60s. |         | OK                    | OK                    |
| Isolation Resistance (MΩ) | 100M Ω min. (500Vdc 60s)                 |         | 1.0 x 10 <sup>7</sup> | 1.0 x 10 <sup>7</sup> |

#### 4. Humidity Test

MODEL : RSEN-2200 (Representation Product : RTHN-5150)

##### (1) Equipment Used

TEMP. & HUMID. CHAMBER PR-4KT (ESPEC CORP.)

##### (2) The Number of D.U.T. (Device Under Test)

2 units

##### (3) Test Conditions

- Ambient Temperature : +40°C
- Test Time : 500 hours
- Ambient Humidity : 90~95% RH No Dewdrop

##### (4) Test Method

Before the test check if there is no abnormal characteristics and put the D.U.T. in the testing chamber. Then test it in the above conditions. After the test is completed leave it for 1 hour at room temperature and check it if there is no abnormal each characteristics.

##### (5) Test Results

PASS

##### Typical Sample Data

| Check item                | Spec.                                    |         | Before Test           | After Test            |
|---------------------------|--|---------|-----------------------|-----------------------|
| Attenuation (dB)          | Differential Mode : 25dBmin.             | 0.2 MHz | 71.45                 | 74.75                 |
|                           |  | 30 MHz  | 54.85                 | 49.00                 |
|                           | Common Mode : 25dBmin.                   | 0.1 MHz | 33.40                 | 33.50                 |
|                           |  | 10 MHz  | 39.15                 | 39.90                 |
| Leakage Current (mA)      | 5mA max.(500V, 60Hz)                     | Line1   | 2.71                  | 2.66                  |
|                           |  | Line2   | 2.70                  | 2.66                  |
|                           |  | Line3   | 2.69                  | 2.66                  |
| DC Resistance (mΩ)        | 6m Ω max.                                |         | 2.51                  | 2.44                  |
| Test Voltage              | L-L : 2192Vdc 60s.<br>L-E : 2500Vac 60s. |         | OK                    | OK                    |
| Isolation Resistance (MΩ) | 100M Ω min. (500Vdc 60s)                 |         | 1.0 x 10 <sup>7</sup> | 1.0 x 10 <sup>7</sup> |

## 5. High Temperature Resistance Test

MODEL : RSEN-2200 (Representation Product : RTHN-5300)

### (1) Equipment Used

TEMPERATURE CHAMBER PHH-300 ( ESPEC CORP.)

### (2) The Number of D.U.T. (Device Under Test)

2 units

### (3) Test Conditions

- Ambient Temperature : +50°C
- Test Time : 500 hours
- Operating : DC 300A

### (4) Test Method

Before the test check if there is no abnormal characteristics and put the D.U.T. in the testing chamber. Then test it in the above conditions. After the test is completed leave it for 1 hour at room temperature and check it if there is no abnormal each characteristics.

### (5) Test Results

PASS

#### Typical Sample Data

| Check item                | Spec.                                    |         | Before Test           | After Test            |
|---------------------------|--|---------|-----------------------|-----------------------|
| Attenuation (dB)          | Differential Mode : 25dBmin.             | 0.2 MHz | 75.80                 | 78.15                 |
|                           |  | 30 MHz  | 34.25                 | 38.60                 |
|                           | Common Mode : 25dBmin.                   | 0.5 MHz | 34.15                 | 34.40                 |
|                           |  | 6 MHz   | 38.60                 | 29.55                 |
| Leakage Current (mA)      | 5mA max.(500V, 60Hz)                     | Line1   | 2.72                  | 2.65                  |
|                           |  | Line2   | 2.72                  | 2.66                  |
|                           |  | Line3   | 2.72                  | 2.66                  |
| DC Resistance (mΩ)        | 2m Ω max.                                |         | 1.02                  | 0.99                  |
| Test Voltage              | L-L : 2192Vdc 60s.<br>L-E : 2500Vac 60s. |         | OK                    | OK                    |
| Isolation Resistance (MΩ) | 100M Ω min. (500Vdc 60s)                 |         | 1.0 x 10 <sup>7</sup> | 1.0 x 10 <sup>7</sup> |

## 6. Low Temperature Storage Test

MODEL : RSEN-2200 (Representation Product : RTHN-5150)

### (1) Equipment Used

TEMPERATURE CHAMBER PG-2FT ( ESPEC CORP.)

### (2) The Number of D.U.T. (Device Under Test)

2 units

### (3) Test Conditions

- Ambient Temperature : -25°C
- Test Time : 500 hours

### (4) Test Method

Before the test check if there is no abnormal characteristics and put the D.U.T. in the testing chamber. Then test it in the above conditions. After the test is completed leave it for 1 hour at room temperature and check it if there is no abnormal each characteristics.

### (5) Test Results

PASS

#### Typical Sample Data

| Check item                | Spec.                                    |         | Before Test           | After Test            |
|---------------------------|--|---------|-----------------------|-----------------------|
| Attenuation (dB)          | Differential Mode : 25dBmin.             | 0.2 MHz | 69.10                 | 71.70                 |
|                           |  | 30 MHz  | 54.25                 | 63.80                 |
|                           | Common Mode : 25dBmin.                   | 0.1 MHz | 32.85                 | 32.90                 |
|                           |  | 10 MHz  | 40.20                 | 40.40                 |
| Leakage Current (mA)      | 5mA max.(500V, 60Hz)                     | Line1   | 2.73                  | 2.65                  |
|                           |  | Line2   | 2.69                  | 2.65                  |
|                           |  | Line3   | 2.69                  | 2.65                  |
| DC Resistance (mΩ)        | 6m Ω max.                                |         | 2.48                  | 2.45                  |
| Test Voltage              | L-L : 2192Vdc 60s.<br>L-E : 2500Vac 60s. |         | OK                    | OK                    |
| Isolation Resistance (MΩ) | 100M Ω min. (500Vdc 60s)                 |         | 1.0 x 10 <sup>7</sup> | 1.0 x 10 <sup>7</sup> |